

BF1214

Dual N-channel dual gate MOSFET

Rev. 01 — 30 October 2007

Product data sheet

1. Product profile

1.1 General description

The BF1214 is a combination of two dual gate MOSFET amplifiers with shared source and gate2 leads.

The source and substrate are interconnected. Internal bias circuits enable DC stabilization and a very good cross modulation performance during AGC. Integrated diodes between the gates and source protect against excessive input voltage surges. The transistor has a SOT363 micro-miniature plastic package.

CAUTION



This device is sensitive to ElectroStatic Discharge (ESD). Therefore care should be taken during transport and handling.

1.2 Features

- Two low noise gain controlled amplifiers in a single package; both with a partly integrated bias
- Superior cross modulation performance during AGC
- High forward transfer admittance
- High forward transfer admittance to input capacitance ratio
- Both amplifiers optimized for VHF applications, yet suitable for VHF and UHF applications

1.3 Applications

- Gain controlled low noise amplifiers for VHF and UHF applications with 5 V supply voltage
 - ◆ digital and analog television tuners
 - ◆ professional communication equipment

1.4 Quick reference data

Table 1. Quick reference data for amplifier A and B

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V _{DS}	drain-source voltage	DC	-	-	6	V
I _D	drain current	DC	-	-	30	mA
P _{tot}	total power dissipation	T _{sp} ≤ 107 °C	[1]	-	180	mW
y _{fs}	forward transfer admittance	f = 100 MHz; T _j = 25 °C; I _D = 18 mA	27	32	37	mS
C _{iss} (G1)	input capacitance at gate1	f = 100 MHz	[2]	-	2.2	pF
C _{rss}	reverse transfer capacitance	f = 100 MHz	[2]	-	20	fF
NF	noise figure	f = 400 MHz; Y _S = Y _{S(opt)}	-	0.9	1.5	dB
		f = 800 MHz; Y _S = Y _{S(opt)}	-	1.2	1.8	dB
Xmod	cross modulation	input level for k = 1 % at 40 dB AGC; f _w = 50 MHz; f _{unw} = 60 MHz	[3]	102	105	- dBμV
T _j	junction temperature		-	-	150	°C

- [1] T_{sp} is the temperature at the soldering point of the source lead.
- [2] Calculated from S-parameters.
- [3] Measured in [Figure 24](#) test circuit.

2. Pinning information

Table 2. Discrete pinning

Pin	Description	Simplified outline	Symbol
1	drain (AMP A)		
2	source		
3	drain (AMP B)		
4	gate1 (AMP B)		
5	gate2		
6	gate1 (AMP A)		

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BF1214	-	plastic surface-mounted package; 6 leads	SOT363

4. Marking

Table 4. Marking		
Type number	Marking	Description
BF1214	SB*	* = p : made in Hong Kong
		* = t : made in Malaysia
		* = w : made in China

5. Limiting values

Table 5. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Per MOSFET					
V _{DS}	drain-source voltage	DC	-	6	V
I _D	drain current	DC	-	30	mA
I _{G1}	gate1 current		-	±10	mA
I _{G2}	gate2 current		-	±10	mA
P _{tot}	total power dissipation	T _{sp} ≤ 107 °C [1]	-	180	mW
T _{stg}	storage temperature		-65	+150	°C
T _j	junction temperature		-	150	°C

[1] T_{sp} is the temperature at the soldering point of the source lead.

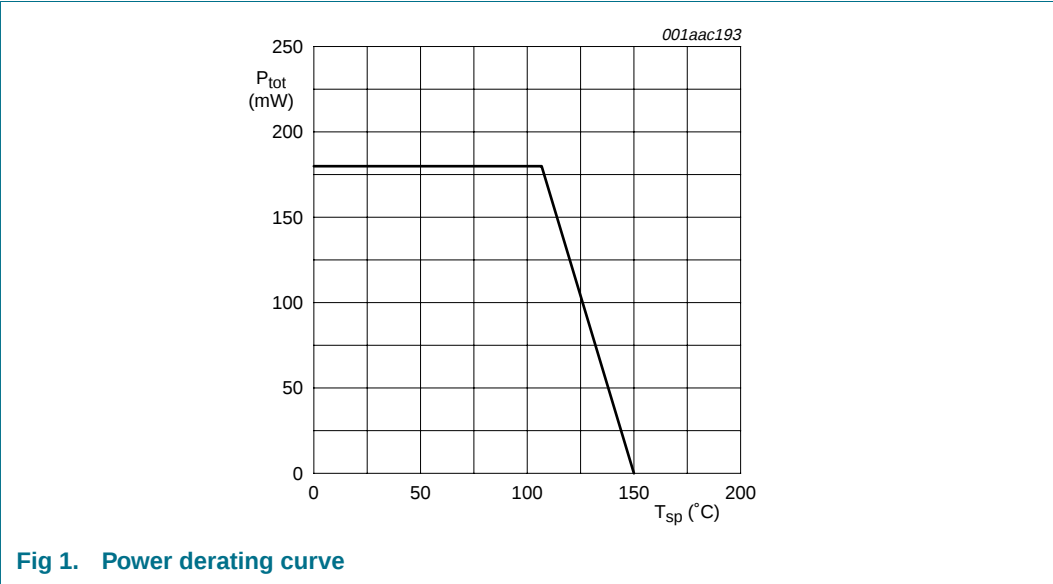


Fig 1. Power derating curve

6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Typ	Unit
$R_{th(j-sp)}$	thermal resistance from junction to solder point		240	K/W

7. Static characteristics

Table 7. Static characteristics

$T_j = 25\text{ }^{\circ}\text{C}$.

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Per MOSFET; unless otherwise specified						
$V_{(BR)DSS}$	drain-source breakdown voltage	$V_{G1-S} = V_{G2-S} = 0\text{ V}$; $I_D = 10\text{ }\mu\text{A}$				
		amplifier A	6	-	-	V
		amplifier B	6	-	-	V
$V_{(BR)G1-SS}$	gate1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0\text{ V}$; $I_{G1-S} = 10\text{ mA}$	6	-	10	V
$V_{(BR)G2-SS}$	gate2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0\text{ V}$; $I_{G2-S} = 10\text{ mA}$	6	-	10	V
$V_{F(S-G1)}$	forward source-gate1 voltage	$V_{G2-S} = V_{DS} = 0\text{ V}$; $I_{S-G1} = 10\text{ mA}$	0.5	-	1.5	V
$V_{F(S-G2)}$	forward source-gate2 voltage	$V_{G1-S} = V_{DS} = 0\text{ V}$; $I_{S-G2} = 10\text{ mA}$	0.5	-	1.5	V
$V_{G1-S(th)}$	gate1-source threshold voltage	$V_{DS} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_D = 100\text{ }\mu\text{A}$	0.3	-	1.0	V
$V_{G2-S(th)}$	gate2-source threshold voltage	$V_{DS} = 5\text{ V}$; $V_{G1-S} = 5\text{ V}$; $I_D = 100\text{ }\mu\text{A}$	0.4	-	1.0	V
I_{DS}	drain-source current	$V_{G2-S} = 4\text{ V}$	[1]			
		amplifier A; $V_{DS(A)} = 5\text{ V}$; $R_{G1(A)} = 68\text{ k}\Omega$	13	-	23	mA
		amplifier B; $V_{DS(B)} = 5\text{ V}$; $R_{G1(B)} = 68\text{ k}\Omega$	13	-	23	mA
I_{G1-S}	gate1 cut-off current	$V_{G2-S} = 0\text{ V}$; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$				
		amplifier A; $V_{G1-S(A)} = 5\text{ V}$	-	-	50	nA
		amplifier B; $V_{G1-S(B)} = 5\text{ V}$	-	-	50	nA
I_{G2-S}	gate2 cut-off current	$V_{G2-S} = 4\text{ V}$; $V_{DS(A)} = V_{DS(B)} = 0\text{ V}$; $V_{G1-S(A)} = V_{G1-S(B)} = 0\text{ V}$	-	-	20	nA

[1] R_{G1} connects gate1 to $V_{GG} = 5\text{ V}$.

8. Dynamic characteristics

Table 8. Dynamic characteristics for amplifier A and B

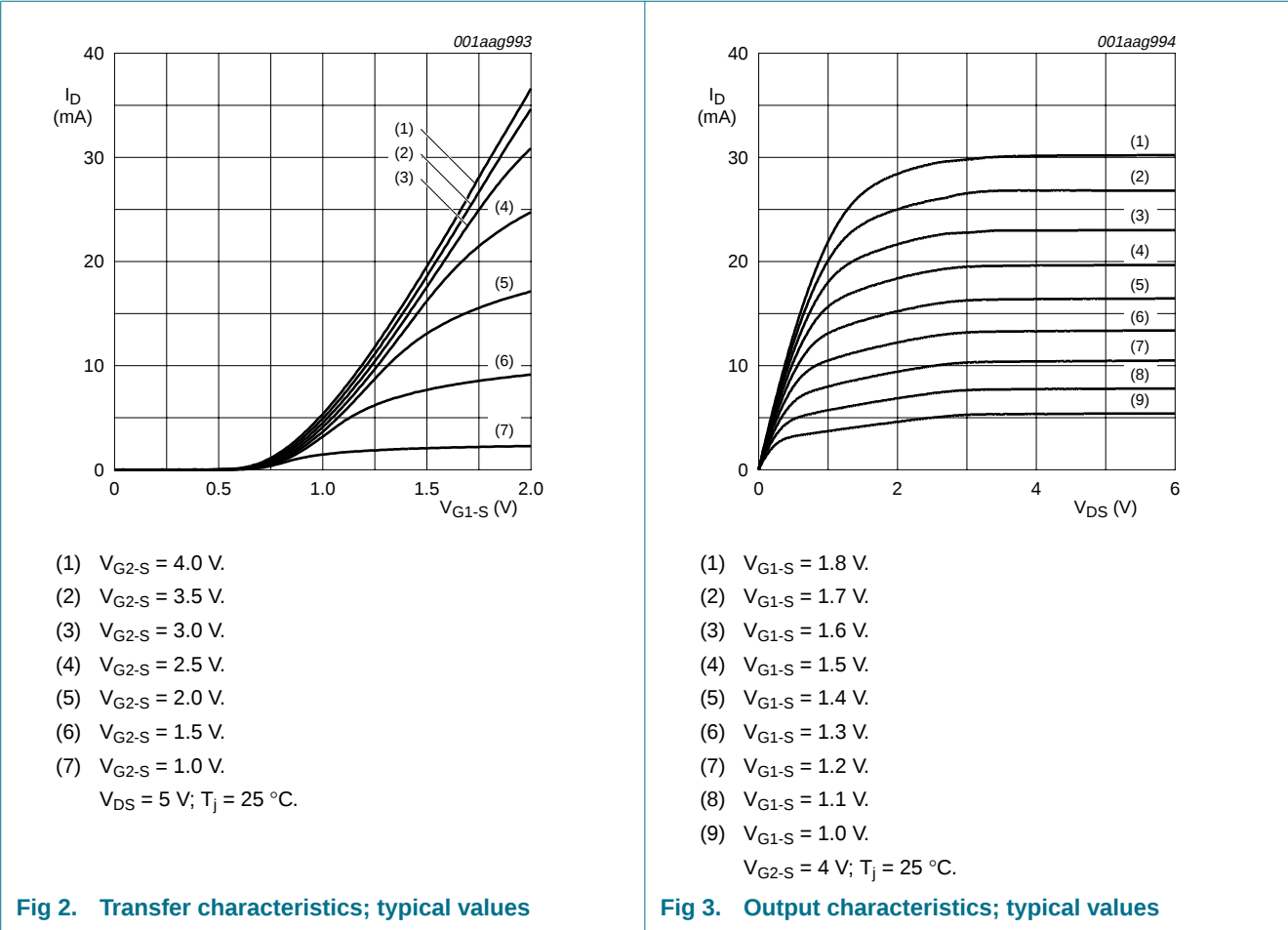
Common source; $T_{amb} = 25\text{ }^{\circ}\text{C}$; $V_{G2-S} = 4\text{ V}$; $V_{DS} = 5\text{ V}$; $I_D = 18\text{ mA}$.

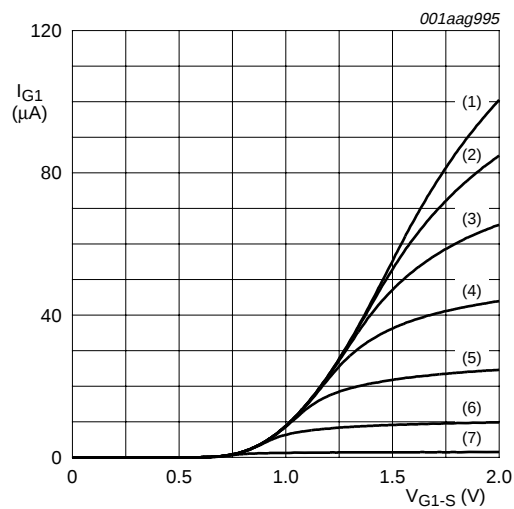
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$ y_{fs} $	forward transfer admittance	$f = 100\text{ MHz}$; $T_j = 25\text{ }^{\circ}\text{C}$	27	32	37	mS
$C_{iss(G1)}$	input capacitance at gate1	$f = 100\text{ MHz}$	[1] -	2.2	2.7	pF
$C_{iss(G2)}$	input capacitance at gate2	$f = 100\text{ MHz}$	[1] -	3.5	-	pF
C_{oss}	output capacitance	$f = 100\text{ MHz}$	[1] -	0.8	-	pF
C_{rss}	reverse transfer capacitance	$f = 100\text{ MHz}$	[1] -	20	-	fF
G_{tr}	transducer power gain	amplifier A; $B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$	[1]			
		$f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 0.5\text{ mS}$	31	35	39	dB
		$f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 1\text{ mS}$	27	31	35	dB
		$f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $G_L = 1\text{ mS}$	22	26	30	dB
		amplifier B; $B_S = B_{S(opt)}$; $B_L = B_{L(opt)}$	[1]			
		$f = 200\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 0.5\text{ mS}$	31	35	39	dB
		$f = 400\text{ MHz}$; $G_S = 2\text{ mS}$; $G_L = 1\text{ mS}$	29	33	37	dB
		$f = 800\text{ MHz}$; $G_S = 3.3\text{ mS}$; $G_L = 1\text{ mS}$	25	29	33	dB
NF	noise figure	$f = 11\text{ MHz}$; $G_S = 20\text{ mS}$; $B_S = 0\text{ S}$	-	3.0	-	dB
		$f = 400\text{ MHz}$; $Y_S = Y_{S(opt)}$	-	0.9	1.5	dB
		$f = 800\text{ MHz}$; $Y_S = Y_{S(opt)}$	-	1.2	1.8	dB
Xmod	cross modulation	input level for $k = 1\%$; $f_w = 50\text{ MHz}$; $f_{unw} = 60\text{ MHz}$	[2]			
		at 0 dB AGC	90	-	-	dB μ V
		at 10 dB AGC	-	94	-	dB μ V
		at 20 dB AGC	-	99	-	dB μ V
		at 40 dB AGC	102	105	-	dB μ V

[1] Calculated from S-parameters.

[2] Measured in [Figure 24](#) test circuit.

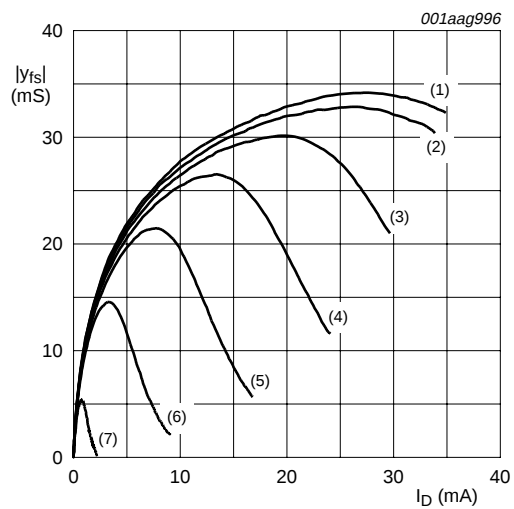
8.1 Graphs for amplifier A and B





- (1) $V_{G2-S} = 4.0$ V.
 - (2) $V_{G2-S} = 3.5$ V.
 - (3) $V_{G2-S} = 3.0$ V.
 - (4) $V_{G2-S} = 2.5$ V.
 - (5) $V_{G2-S} = 2.0$ V.
 - (6) $V_{G2-S} = 1.5$ V.
 - (7) $V_{G2-S} = 1.0$ V.
- $V_{DS} = 5$ V; $T_j = 25$ °C.

Fig 4. Gate1 current as a function of gate1 voltage; typical values



- (1) $V_{G2-S} = 4.0$ V.
 - (2) $V_{G2-S} = 3.5$ V.
 - (3) $V_{G2-S} = 3.0$ V.
 - (4) $V_{G2-S} = 2.5$ V.
 - (5) $V_{G2-S} = 2.0$ V.
 - (6) $V_{G2-S} = 1.5$ V.
 - (7) $V_{G2-S} = 1.0$ V.
- $V_{DS} = 5$ V; $T_j = 25$ °C.

Fig 5. Forward transfer admittance as a function of drain current; typical values

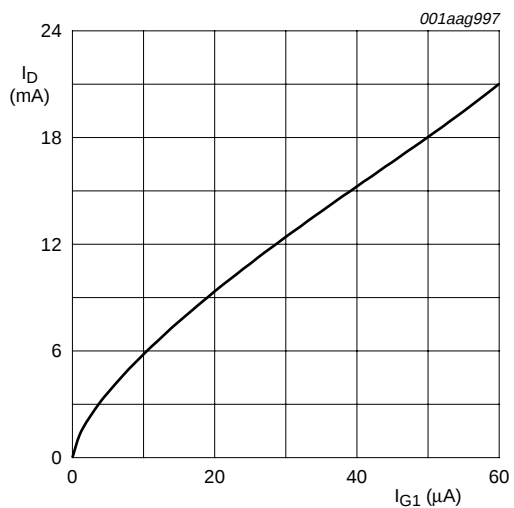


Fig 6. Drain current as a function of gate1 current; typical values

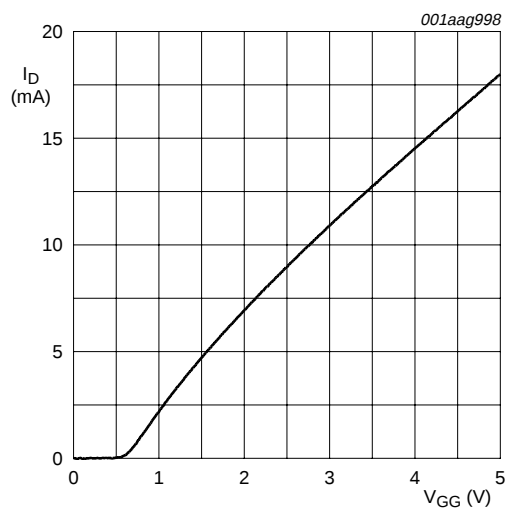
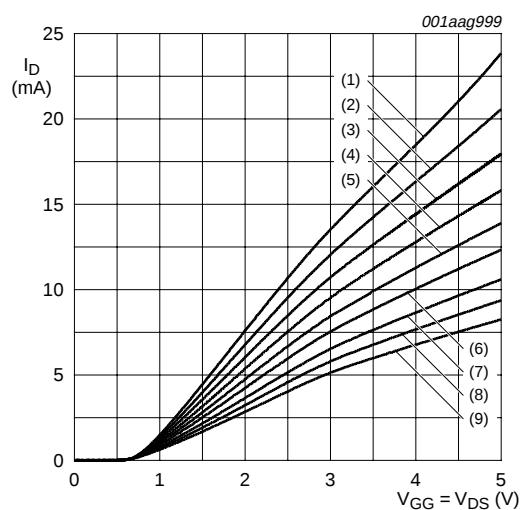
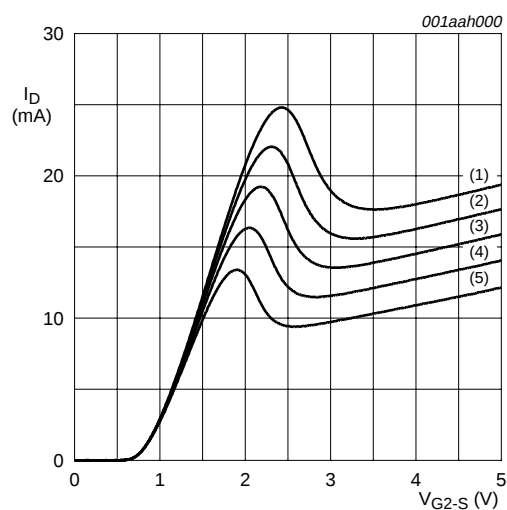


Fig 7. Drain current as a function of gate1 supply voltage (V_{GG}); typical values



- (1) $R_{G1} = 47 \text{ k}\Omega$.
 - (2) $R_{G1} = 56 \text{ k}\Omega$.
 - (3) $R_{G1} = 68 \text{ k}\Omega$.
 - (4) $R_{G1} = 82 \text{ k}\Omega$.
 - (5) $R_{G1} = 100 \text{ k}\Omega$.
 - (6) $R_{G1} = 120 \text{ k}\Omega$.
 - (7) $R_{G1} = 150 \text{ k}\Omega$.
 - (8) $R_{G1} = 180 \text{ k}\Omega$.
 - (9) $R_{G1} = 220 \text{ k}\Omega$.
- $V_{G2-S} = 4 \text{ V}$; $T_j = 25 \text{ }^\circ\text{C}$.

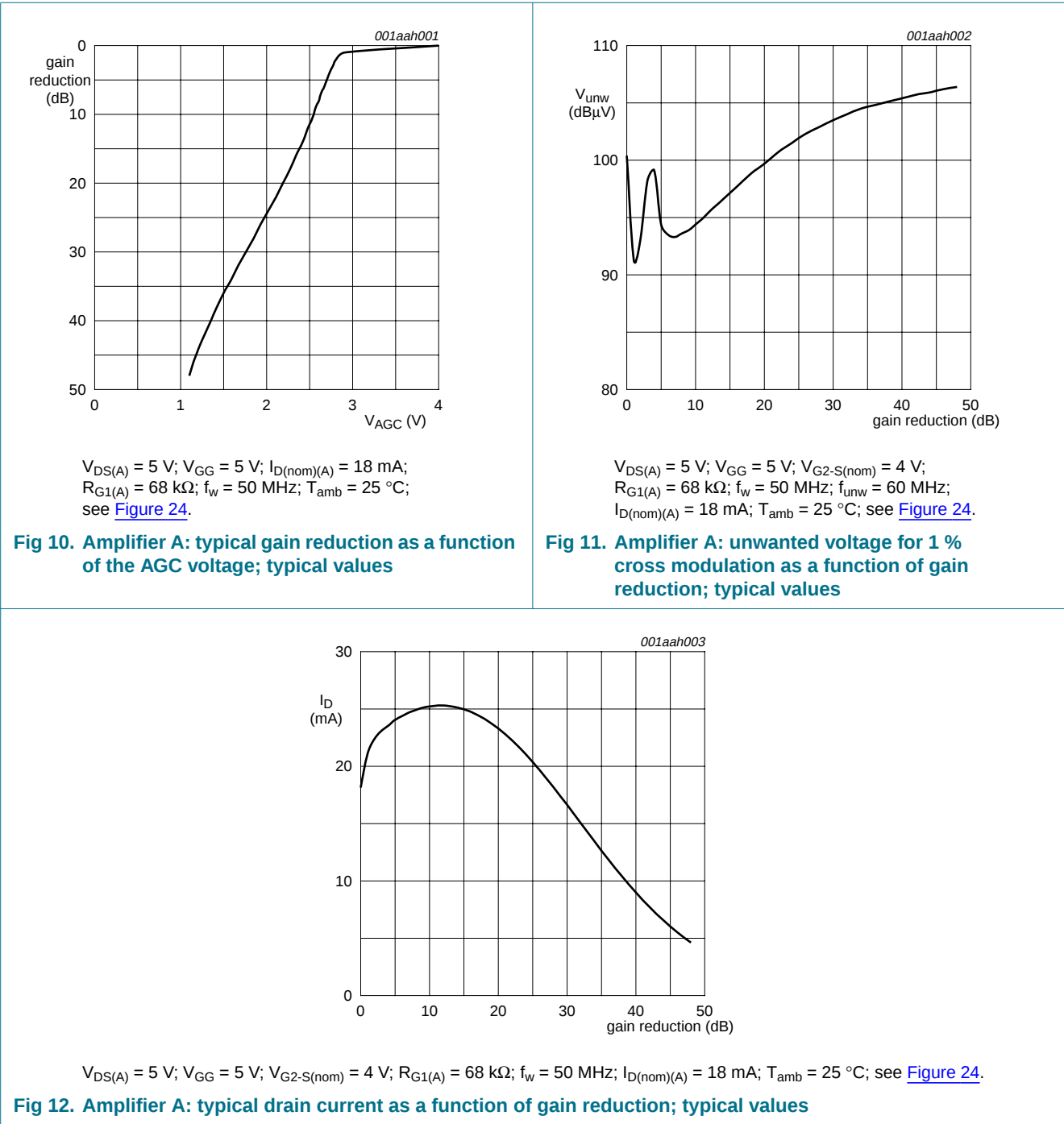
Fig 8. Drain current as a function of V_{DS} and V_{GG} ; typical values

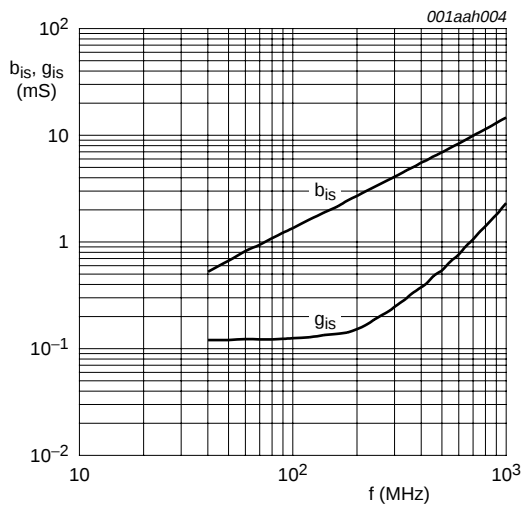


- (1) $V_{GG} = 5.0 \text{ V}$.
 - (2) $V_{GG} = 4.5 \text{ V}$.
 - (3) $V_{GG} = 4.0 \text{ V}$.
 - (4) $V_{GG} = 3.5 \text{ V}$.
 - (5) $V_{GG} = 3.0 \text{ V}$.
- $T_j = 25 \text{ }^\circ\text{C}$; $R_{G1} = 68 \text{ k}\Omega$ (connected to V_{GG}).

Fig 9. Drain current as a function of gate2 voltage; typical values

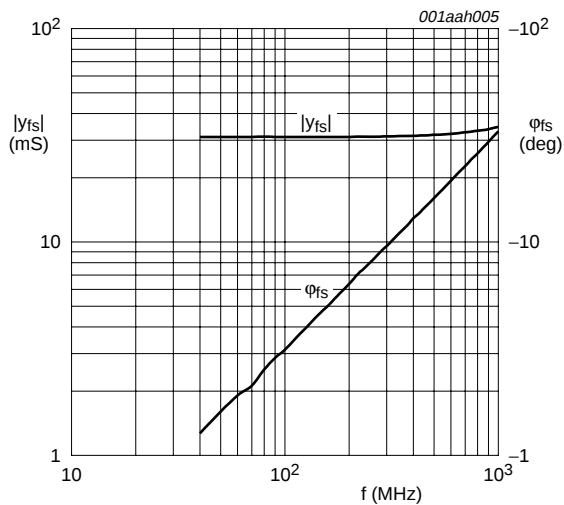
8.2 Graphs for amplifier A





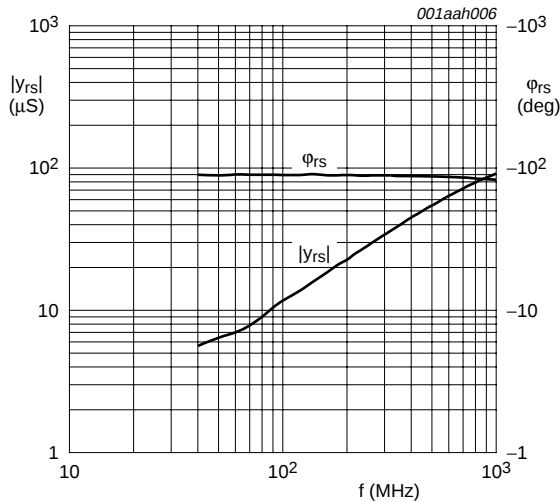
$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 0\text{ V}$;
 $I_{D(A)} = 18\text{ mA}$.

Fig 13. Amplifier A: input admittance as a function of frequency; typical values



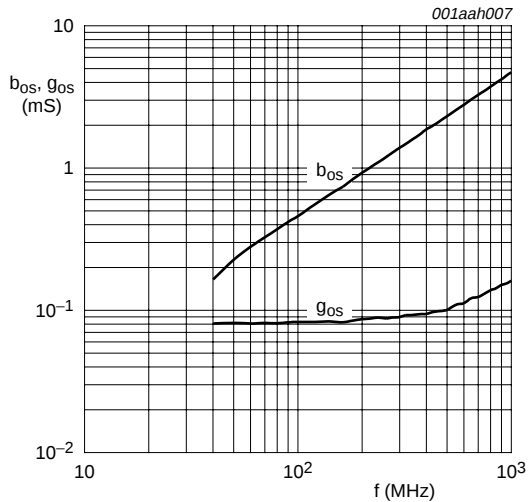
$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 0\text{ V}$;
 $I_{D(A)} = 18\text{ mA}$.

Fig 14. Amplifier A: forward transfer admittance and phase as a function of frequency; typical values



$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 0\text{ V}$;
 $I_{D(A)} = 18\text{ mA}$.

Fig 15. Amplifier A: reverse transfer admittance and phase as a function of frequency; typical values



$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $V_{DS(B)} = 0\text{ V}$;
 $I_{D(A)} = 18\text{ mA}$.

Fig 16. Amplifier A: output admittance as a function of frequency; typical values

8.2.1 Scattering parameters for amplifier A

Table 9. Scattering parameters for amplifier A

$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(A)} = 18\text{ mA}$; $V_{DS(B)} = 0\text{ V}$; $V_{G1-S(B)} = 0\text{ V}$; $T_{amb} = 25\text{ °C}$; typical values.

f (MHz)	S ₁₁		S ₂₁		S ₁₂		S ₂₂	
	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)
40	0.9877	−3.07	3.07	176.73	0.0006	88.01	0.9902	−1.00
100	0.9888	−7.81	3.07	171.67	0.0012	85.54	0.9918	−2.74
200	0.9852	−15.61	3.04	163.23	0.0022	80.05	0.9910	−5.50
300	0.9766	−23.41	3.00	154.91	0.0033	75.66	0.9896	−8.22
400	0.9643	−31.14	2.95	146.63	0.0042	71.57	0.9881	−10.93
500	0.9504	−38.62	2.89	138.57	0.0050	67.10	0.9859	−13.61
600	0.9339	−45.96	2.82	130.61	0.0056	63.38	0.9836	−16.28
700	0.9151	−53.13	2.74	122.79	0.0061	59.74	0.9813	−18.96
800	0.8960	−60.18	2.66	115.17	0.0064	56.44	0.9790	−21.60
900	0.8766	−67.00	2.57	107.66	0.0065	53.53	0.9769	−24.20
1000	0.8564	−73.58	2.49	100.35	0.0066	50.29	0.9753	−26.88

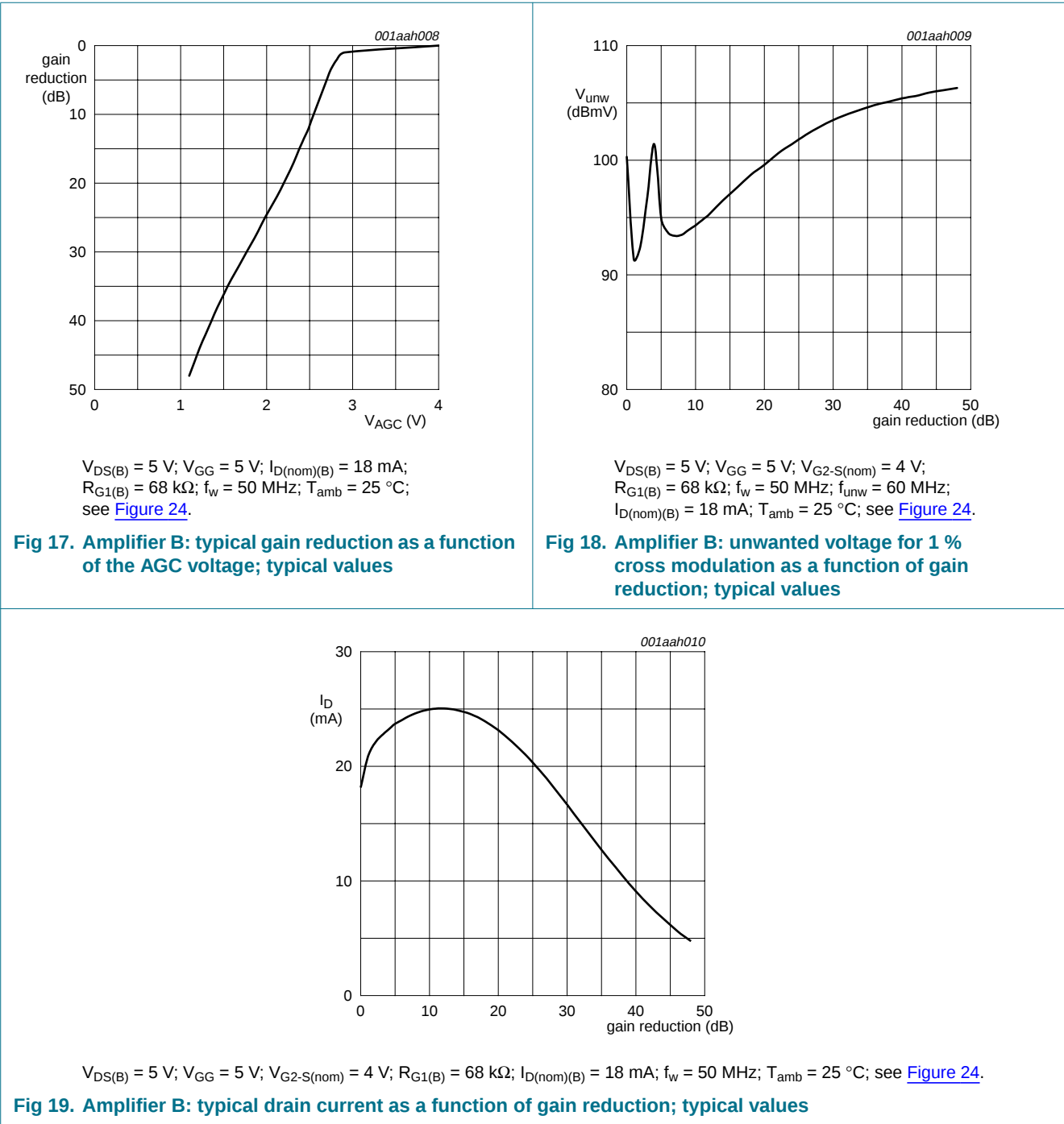
8.2.2 Noise data for amplifier A

Table 10. Noise data for amplifier A

$V_{DS(A)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(A)} = 18\text{ mA}$; $T_{amb} = 25\text{ °C}$; typical values.

f (MHz)	NF _{min} (dB)	Γ _{opt}		r _n (ratio)
		(ratio)	(deg)	
400	0.91	0.76	23.60	0.677
800	1.23	0.71	48.91	0.620

8.3 Graphs for amplifier B



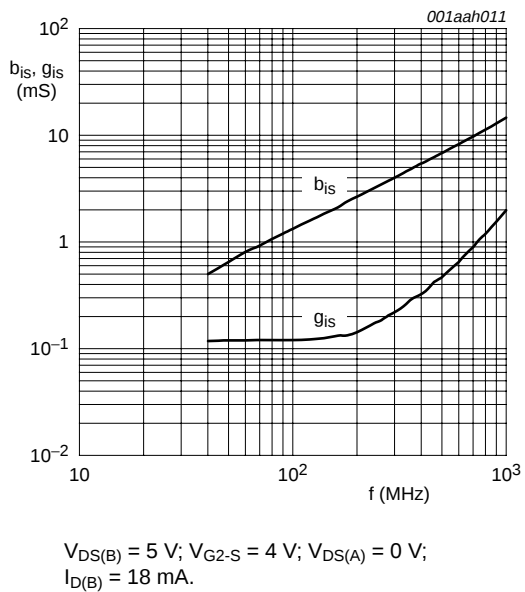


Fig 20. Amplifier B: input admittance as a function of frequency; typical values

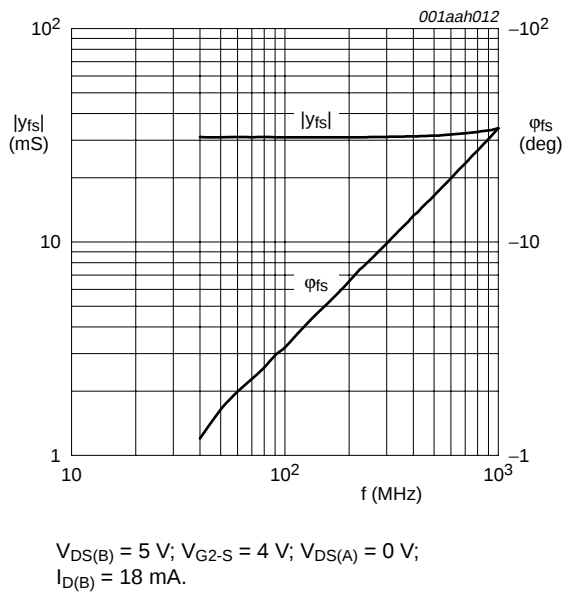


Fig 21. Amplifier B: forward transfer admittance and phase as a function of frequency; typical values

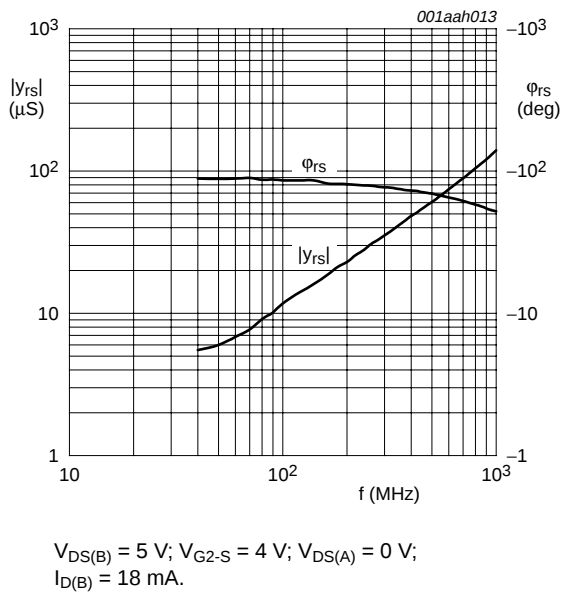


Fig 22. Amplifier B: reverse transfer admittance and phase as a function of frequency; typical values

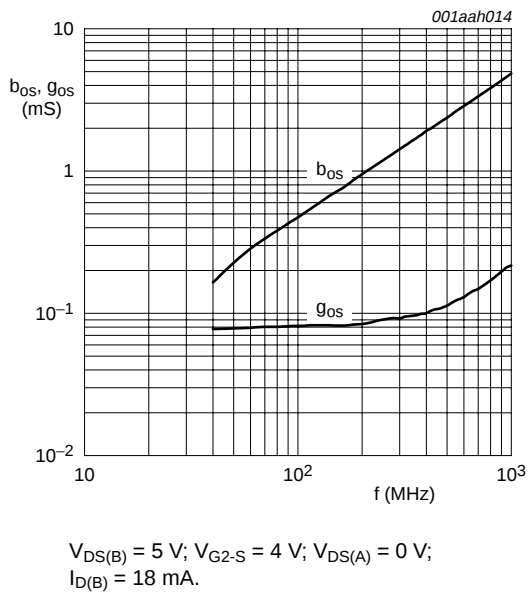


Fig 23. Amplifier B: output admittance as a function of frequency; typical values

8.3.1 Scattering parameters for amplifier B

Table 11. Scattering parameters for amplifier B
 $V_{DS(B)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(B)} = 18\text{ mA}$; $V_{DS(A)} = 0\text{ V}$; $V_{G1-S(A)} = 0\text{ V}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$; typical values.

f (MHz)	S11		S21		S12		S22	
	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)	Magnitude (ratio)	Angle (deg)
40	0.9836	-2.92	3.06	176.89	0.0005	89.71	0.9897	-0.98
100	0.9890	-7.68	3.06	171.63	0.0012	92.19	0.9920	-2.79
200	0.9869	-15.32	3.03	163.14	0.0023	88.94	0.9914	-5.62
300	0.9801	-23.00	2.99	154.74	0.0034	87.64	0.9902	-8.42
400	0.9704	-30.69	2.94	146.34	0.0045	86.52	0.9889	-11.21
500	0.9595	-38.13	2.88	138.13	0.0056	85.29	0.9869	-14.01
600	0.9458	-45.45	2.81	129.99	0.0066	84.60	0.9845	-16.81
700	0.9300	-52.67	2.73	121.93	0.0075	83.78	0.9818	-19.64
800	0.9132	-59.82	2.65	114.01	0.0085	82.86	0.9786	-22.44
900	0.8959	-66.74	2.56	106.18	0.0093	81.97	0.9750	-25.22
1000	0.8775	-73.43	2.47	98.51	0.0101	80.62	0.9717	-28.10

8.3.2 Noise data for amplifier B

Table 12. Noise data for amplifier B
 $V_{DS(B)} = 5\text{ V}$; $V_{G2-S} = 4\text{ V}$; $I_{D(B)} = 18\text{ mA}$; $T_{amb} = 25\text{ }^{\circ}\text{C}$; typical values.

f (MHz)	NF _{min} (dB)	Γ_{opt}		r_n (ratio)
		(ratio)	(deg)	
400	0.91	0.76	22.58	0.690
800	1.24	0.71	47.34	0.620

9. Test information

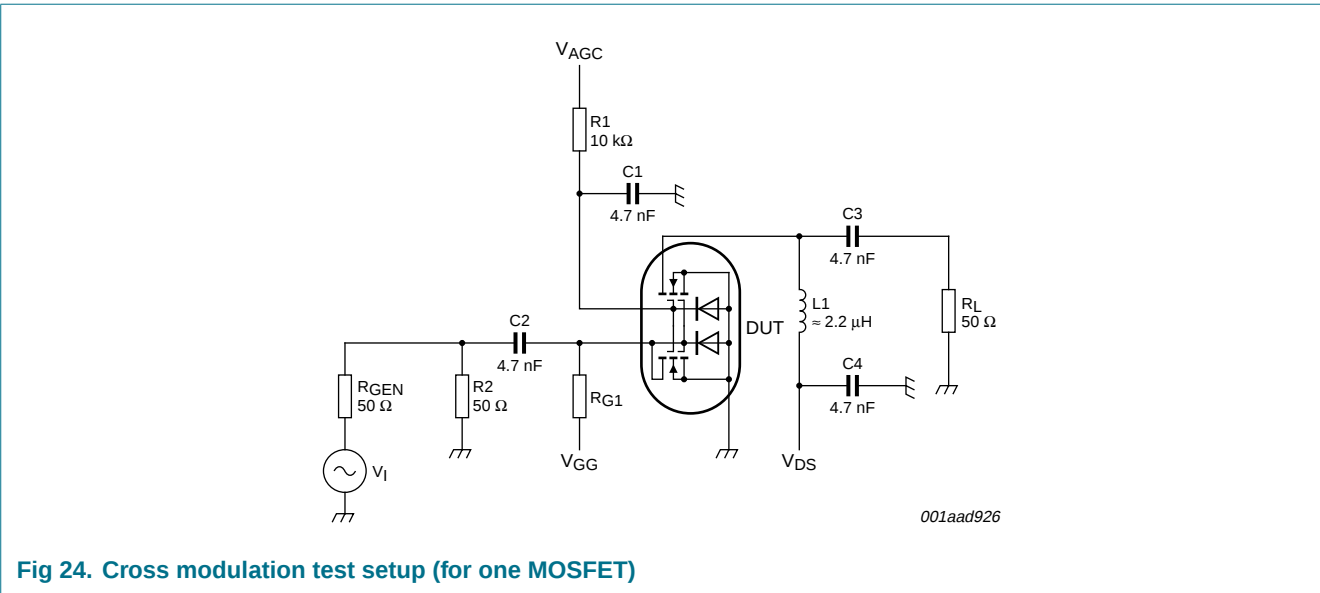


Fig 24. Cross modulation test setup (for one MOSFET)

10. Package outline

Plastic surface-mounted package; 6 leads

SOT363

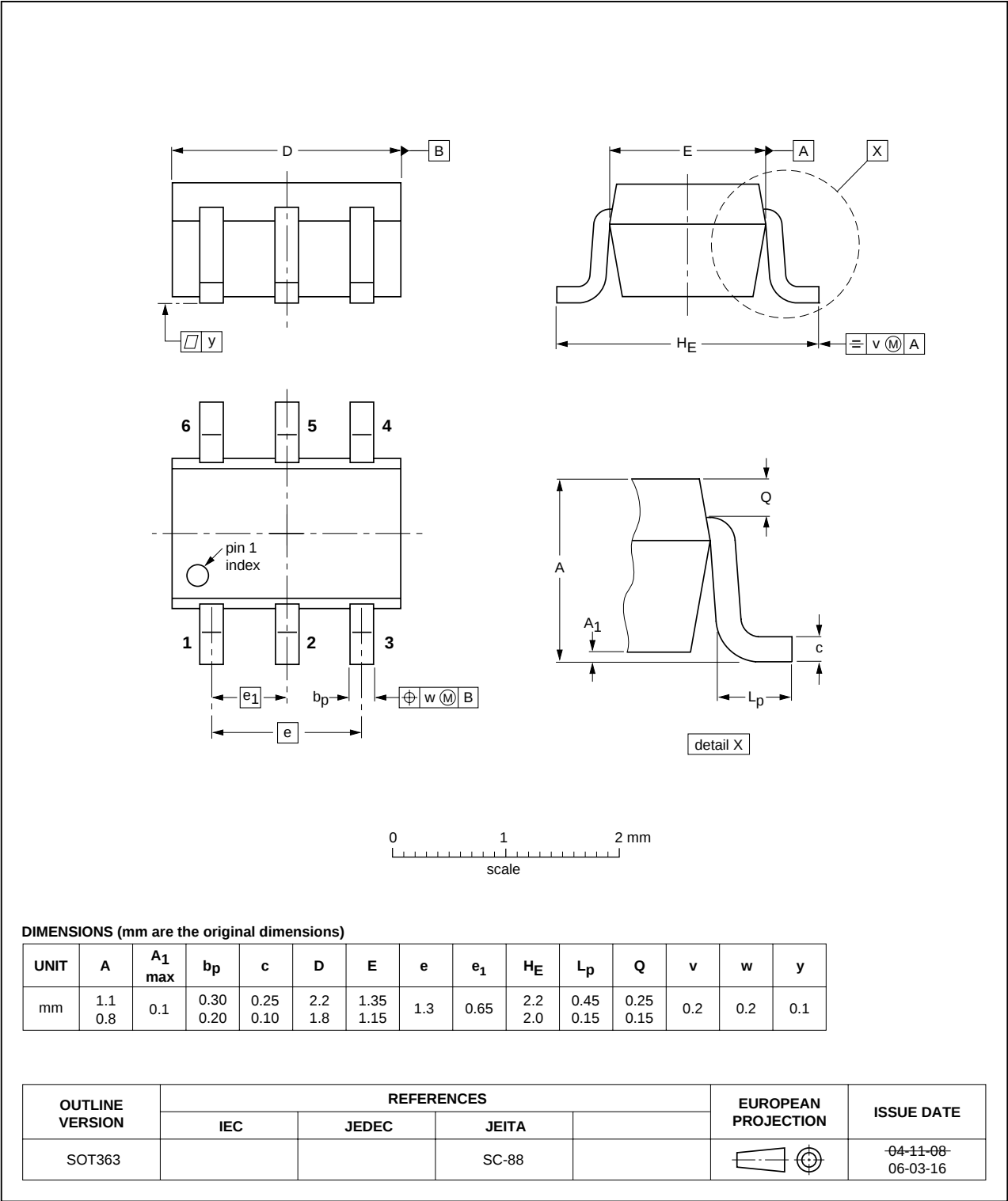


Fig 25. Package outline SOT363

11. Abbreviations

Table 13. Abbreviations

Acronym	Description
AGC	Automatic Gain Control
DC	Direct Current
MOSFET	Metal-Oxide-Semiconductor Field-Effect Transistor
UHF	Ultra High Frequency
VHF	Very High Frequency

12. Revision history

Table 14. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
BF1214_1	20071030	Product data sheet	-	-

13. Legal information

13.1 Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

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